

UTC UNISONIC TECHNOLOGIES CO., LTD

75NM70

Preliminary

75A, 700V N-CHANNEL SUPER-JUNCTION MOSFET

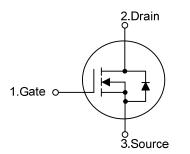
DESCRIPTION

The UTC 75NM70 is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at DC-DC, AC-DC converters for power applications.

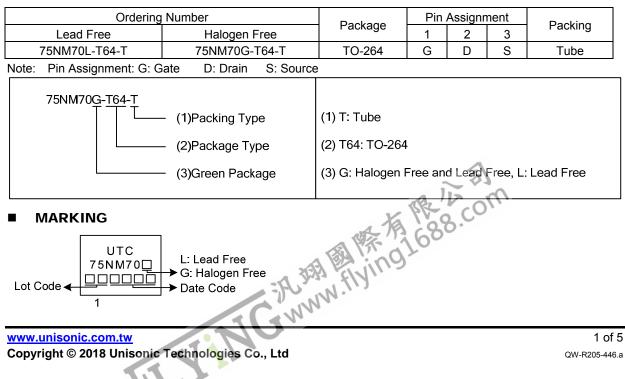
FEATURES

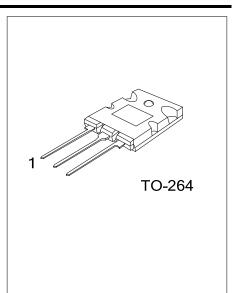
- * R_{DS(ON)} < 70mΩ @ V_{GS} = 10V, I_D = 37.5A
- * Fast switching capability
- * Avalanche energy tested
- * Improved dv/dt capability, high ruggedness

SYMBOL



ORDERING INFORMATION





ABSOLUTE MAXIMUM RATINGS (Tc =25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V _{DSS}	700	V	
Gate-Source Voltage		V _{GSS}	±30	V	
Drain Current	Continuous	I _D	75	А	
	Pulsed (Note 2)	I _{DM}	150	А	
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	922	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	15	V/ns	
Power Dissipation		PD	255	W	
Junction Temperature		ΤJ	+150	°C	
Storage Temperature Range		T _{STG}	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L=5mH, I_{AS} =19.2A, V_{DD} =50V, R_G =25 Ω , Starting T_J = 25°C.
- 4. $I_{SD} \leq 30A$, di/dt $\leq 200A/\mu s$, $V_{DD} \leq V_{(BR)DSS}$, $T_J = 25^{\circ}C$.

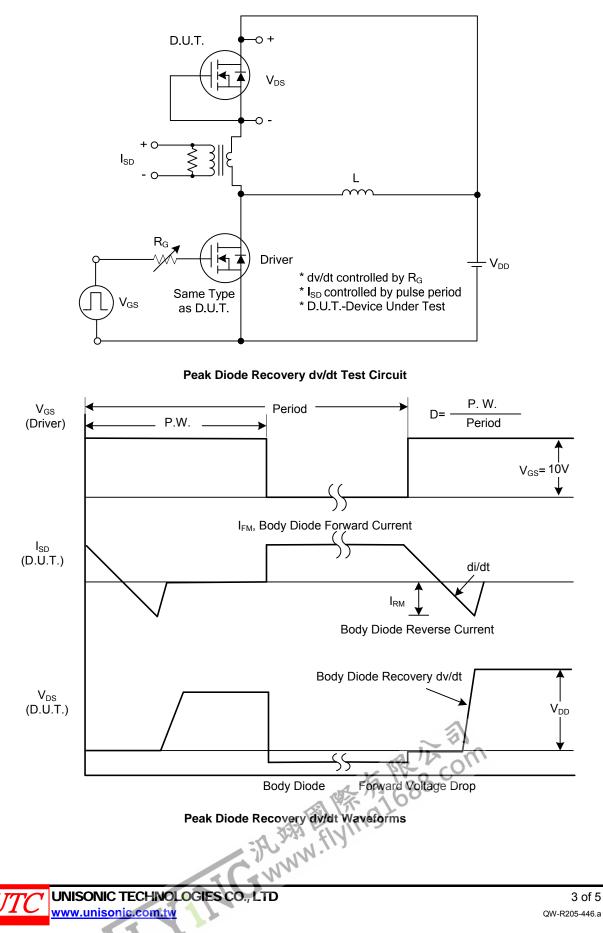
THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	θ_{JA}	40	°C/W	
Junction to Case	θ _{JC}	0.4	°C/W	

ELECTRICAL CHARACTERISTICS (TJ=25°C, unless otherwise specified)

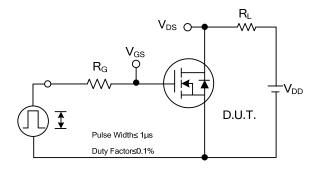
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT					
OFF CHARACTERISTICS											
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250µA	700			V					
Drain-Source Leakage Current	I _{DSS}	V _{DS} =700V, V _{GS} =0V			10	μA					
Gate-Source Leakage Current	I _{GSS}	V _{DS} =0V ,V _{GS} =±30V			±100	nA					
ON CHARACTERISTICS											
Gate Threshold Voltage	V _{GS(TH)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.5		4.5	V					
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} = 10V, I _D = 37.5A			70	mΩ					
DYNAMIC PARAMETERS											
Input Capacitance	CISS			5000		рF					
Output Capacitance	C _{OSS}	V _{GS} =0V, V _{DS} =25V, f=1.0MHz		2500		рF					
Reverse Transfer Capacitance				7		рF					
SWITCHING PARAMETERS											
Total Gate Charge (Note 1)	Q_{G}			205		nC					
Gate to Source Charge	Q _{GS} V _{DS} =300V, V _{GS} =75V,			48		nC					
Gate to Drain Charge	Q_{GD}	$I_D = 1.3A$, $I_G = 111A$ (Note 1, 2)		88		nC					
Turn-ON Delay Time (Note 1)	t _{D(ON)}			96		ns					
Rise Time	t _R	V _{DD} =300V, V _{GS} =10V,		62		ns					
Turn-OFF Delay Time	-OFF Delay Time $t_{D(OFF)}$ I _D =30A, R _G =25 Ω (Note			680		ns					
Fall-Time	t⊨			220		ns					
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS											
Maximum Body-Diode Continuous Current	ls	3			75	Α					
Maximum Body-Diode Pulsed Current	I _{SM}		0		150	Α					
Drain-Source Diode Forward Voltage (Note 1)	V _{SD}	I _S =75A, V _{GS} =0V	1.		1.4	V					
Body Diode Reverse Recovery Time (Note 1)	t _{rr}	I _S =30A, V _{GS} =0V, O		770		ns					
Body Diode Reverse Recovery Charge	Qrr	dl _F /dt=100A/µs		18		μC					
Notes: 1. Pulse Test : Pulse width \leq 300µs, Duty cycle \leq 2%.											
2. Essentially independent of operating temperature.											
Body Didde Reverse Recovery Charge Q _m Querce roc×ps 18 μC Notes: 1. Pulse Test : Pulse width ≤ 300µs, Duty cycle ≤ 2%. 2. Essentially independent of operating temperature. 2.											
- WY											

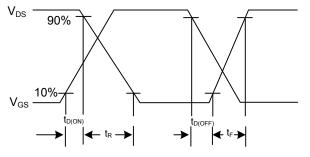
TEST CIRCUITS AND WAVEFORMS



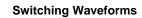
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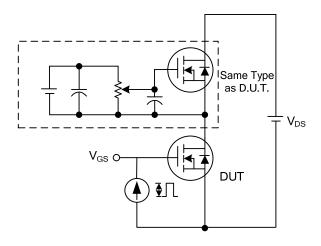
TEST CIRCUITS AND WAVEFORMS (Cont.)



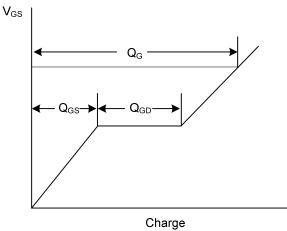


Switching Test Circuit

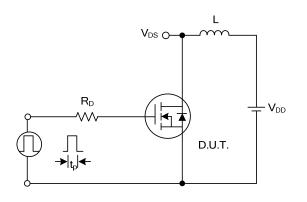




Gate Charge Test Circuit







 $\mathsf{BV}_{\mathsf{DSS}}$ I_{AS} D(t) V_{DS(t)} V_{DD} it Unclamped Inductive Switching Waveforms



Unclamped Inductive Switching Test Circuit

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